

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/492,265	HAO ET AL.	•
Examiner	Art Unit	
Christine Ng	2616	

	SEAR	CHED	
Class	Subclass	Date	Examiner
370	392	1/17/2007	CN
370	395.32	1/17/2007	CN
370	395.7	1/17/2007	CN
370	395.72	1/17/2007	ĊN
370	412	1/17/2007	CN
370	413	1/17/2007	CN
710	56	1/17/2007	CN
710	310	1/17/2007	CN
711	108	1/17/2007	CN
711	131	1/17/2007	CN
711	149	1/17/2007	CN
711	209	1/17/2007	CN
711	216	1/17/2007	CN
711	221	1/17/2007	CN

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
Huy Vu		1/17/2007	CN	
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